Search Notes

 Application/Control No.	Applicant(s)/Patent under Reexamination		
09/938,474	ATHREYA ET AL.		
Examiner	Art Unit		
Afsar M. Qureshi	2667	_	

SEARCHED						
Class	Subclass	Date	Examiner			
370	386	3/16/2006	AQ			
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	401					
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709	204					
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